## Notice of References Cited Application/Control No. 09/783,254 Examiner Hieu Phan Applicant(s)/Patent Under Reexamination SIRHAN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	-A	US-5,283,257	02-1994	Gregory et al.	514/458
	В	US-6,699,493	03-2004	Wong, Vernon G.	424/428
	С	US-6,774,278	08-2004	Ragheb et al.	623/1.1
	D	US-			
	Е	US-			
	ᄔ	US-			
	G	US-			
	н	US-			
	1	US-			
	J	US-			
	К	US-			
	٦	US-			
	М	US-		,	

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0				·	
	Р					
	Q					
	R					
	s					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	٦	
	>	
	w	
	х	·

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.